Application/Control No.	Applicant(s)/Patent under Reexamination
10/709,540	STANZEL ET AL.
Examiner	Art Unit
Len Tran	1725

	SEAR	CHED	
Class	Subclass	Date	Examiner
219	130.1, 136, 74, 75	12/5/2006	LT
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INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
PALM .	12/5/2006	LT	
text search attached	12/5/2006	LT	
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